

N-channel TrenchMOS logic level FET Rev. 02 — 21 April 2011

Product data sheet

Product profile 1.

1.1 General description

Logic level N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using TrenchMOS technology. This product has been designed and qualified to the appropriate AEC standard for use in automotive critical applications.

1.2 Features and benefits

AEC Q101 compliant

Low conduction losses due to low on-state resistance

1.3 Applications

Automotive and general purpose power switching

1.4 Quick reference data

Table 1. Quick reference data

Parameter	Conditions	Min	Тур	Max	Unit
drain-source voltage	T _j ≥ 25 °C; T _j ≤ 175 °C	-	-	55	V
drain current	T _{mb} = 25 °C	-	-	13	А
total power dissipation		-	-	53	W
racteristics					
drain-source on-state resistance	V_{GS} = 10 V; I_D = 13 A; T_j = 25 °C	-	116	137	mΩ
	$V_{GS} = 5 \text{ V}; I_D = 13 \text{ A};$ $T_j = 25 \text{ °C}$	-	125	150	mΩ
e ruggedness					
non-repetitive drain-source avalanche energy	$\begin{split} I_{D} &= 8 \text{ A}; V_{sup} \leq 25 \text{ V}; \\ R_{GS} &= 50 \Omega; V_{GS} = 5 \text{ V}; \\ T_{j(\text{init})} &= 25 ^{\circ}\text{C}; \\ \text{unclamped} \end{split}$	-	-	25	mJ
	drain-source voltage drain current total power dissipation racteristics drain-source on-state resistance ruggedness non-repetitive drain-source	$\label{eq:constraint} \begin{array}{ll} \text{drain-source voltage} & T_j \geq 25 \ ^\circ\text{C}; \ T_j \leq 175 \ ^\circ\text{C} \\ \text{drain current} & T_{mb} = 25 \ ^\circ\text{C} \\ \hline \text{total power dissipation} \\ \hline \text{racteristics} \\ \hline \text{drain-source on-state} & V_{GS} = 10 \ ^\circ\text{V}; \ I_D = 13 \ ^\text{A}; \\ \hline T_j = 25 \ ^\circ\text{C} \\ \hline V_{GS} = 5 \ ^\circ\text{V}; \ I_D = 13 \ ^\text{A}; \\ \hline T_j = 25 \ ^\circ\text{C} \\ \hline \text{eruggedness} \\ \hline \text{non-repetitive drain-source} & I_D = 8 \ ^\text{A}; \ V_{sup} \leq 25 \ ^\text{V}; \\ \hline \text{R}_{GS} = 50 \ ^\circ\text{C}; \ ^\text{V}_{GS} = 5 \ ^\text{V}; \\ \hline \text{T}_{j(init)} = 25 \ ^\circ\text{C}; \end{array}$	$\begin{array}{llllllllllllllllllllllllllllllllllll$	$\begin{array}{cccc} T_{j} \geq 25 \ ^{\circ}\text{C}; \ T_{j} \leq 175 \ ^{\circ}\text{C} & - & - \\ \hline \text{drain current} & T_{mb} = 25 \ ^{\circ}\text{C} & - & - \\ \hline \text{total power dissipation} & & - & - \\ \hline \text{total power dissipation} & & - & - \\ \hline \textbf{racteristics} & & & & \\ \hline \textbf{drain-source on-state} & V_{\text{GS}} = 10 \ \text{V}; \ \textbf{I}_{\text{D}} = 13 \ \text{A}; & - & 116 \\ \hline \textbf{T}_{j} = 25 \ ^{\circ}\text{C} & \\ \hline \textbf{V}_{\text{GS}} = 5 \ \text{V}; \ \textbf{I}_{\text{D}} = 13 \ \text{A}; & - & 125 \\ \hline \textbf{T}_{j} = 25 \ ^{\circ}\text{C} & \\ \hline \textbf{V}_{\text{GS}} = 5 \ \text{V}; \ \textbf{I}_{\text{D}} = 13 \ \text{A}; & - & 125 \\ \hline \textbf{ruggedness} & \\ \hline \textbf{non-repetitive drain-source} & \textbf{I}_{\text{D}} = 8 \ \text{A}; \ \textbf{V}_{\text{sup}} \leq 25 \ \text{V}; & - & - \\ \hline \textbf{R}_{\text{GS}} = 50 \ \Omega; \ \textbf{V}_{\text{GS}} = 5 \ \text{V}; \\ \hline \textbf{T}_{j(\text{init})} = 25 \ ^{\circ}\text{C}; & \\ \end{array}$	$\begin{array}{ccccc} \text{drain-source voltage} & T_j \geq 25 \ ^\circ\text{C}; \ T_j \leq 175 \ ^\circ\text{C} & - & - & 55 \\ \text{drain current} & T_{mb} = 25 \ ^\circ\text{C} & - & - & 13 \\ \text{total power dissipation} & - & - & 53 \\ \hline \textbf{racteristics} & & & & & & & & \\ \hline \textbf{resistance} & V_{GS} = 10 \ \text{V}; \ \textbf{I}_D = 13 \ \text{A}; & - & 116 & 137 \\ \hline \textbf{T}_j = 25 \ ^\circ\text{C} & & & & & & \\ \hline \textbf{V}_{GS} = 5 \ \text{V}; \ \textbf{I}_D = 13 \ \text{A}; & - & 116 & 137 \\ \hline \textbf{T}_j = 25 \ ^\circ\text{C} & & & & & & \\ \hline \textbf{ruggedness} & & & & & & & \\ \hline \textbf{non-repetitive drain-source} & \textbf{I}_D = 8 \ \text{A}; \ \textbf{V}_{sup} \leq 25 \ \text{V}; & - & & & & & & & \\ \hline \textbf{non-repetitive drain-source} & & & & & & & & \\ \hline \textbf{non-repetitive drain-source} & & & & & & & & & & \\ \hline \textbf{non-repetitive drain-source} & & & & & & & & & & & & & \\ \hline \textbf{non-repetitive drain-source} & & & & & & & & & & & & & & & & \\ \hline \textbf{non-repetitive drain-source} & & & & & & & & & & & & & & & & & & &$



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2. Pinning information

Table 2.	Pinning	j information		
Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate		_
2	D	drain	mb	
3	S	source		
mb	D	mounting base; connected to drain		mbb076 S

SOT78A (TO-220AB)

3. Ordering information

Table 3. Ordering information

Type number	Package		
	Name	Description	Version
BUK95150-55A	TO-220AB	plastic single-ended package; heatsink mounted; 1 mounting hole; 3-lead TO-220AB	SOT78A

4. Limiting values

Table 4.Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

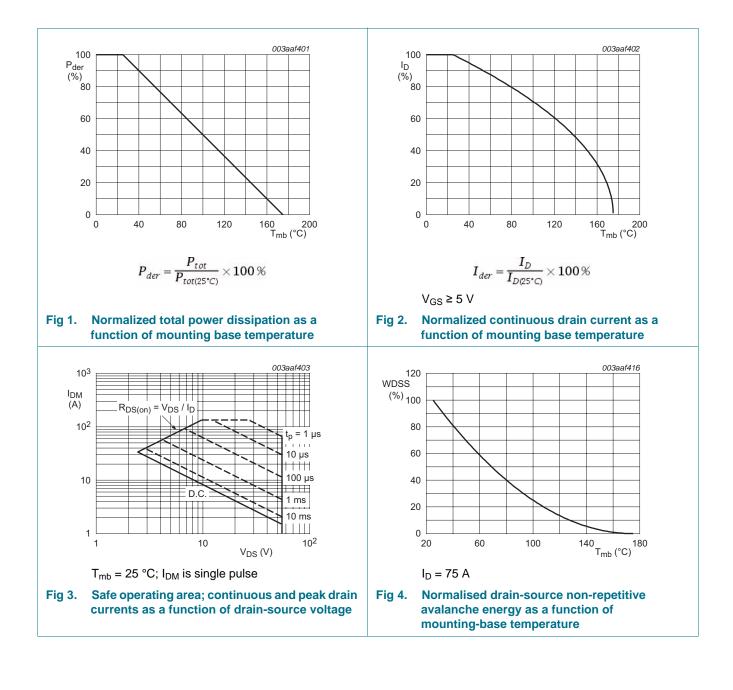
Symbol	Parameter	Conditions	Min	Max	Unit
V _{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 175 °C	-	55	V
V _{DGR}	drain-gate voltage	$R_{GS} = 20 \text{ k}\Omega$	-	55	V
V _{GS}	gate-source voltage		-10	10	V
I _D	drain current	T _{mb} = 25 °C	-	13	А
		T _{mb} = 100 °C	-	9	А
I _{DM}	peak drain current	T _{mb} = 25 °C; pulsed	-	53	А
P _{tot}	total power dissipation	T _{mb} = 25 °C	-	53	W
T _{stg}	storage temperature		-55	175	°C
Tj	junction temperature		-55	175	°C
V _{GSM}	peak gate-source voltage	pulsed; t _p ≤ 50 µs	-15	15	V
Source-drain	n diode				
I _S	source current	T _{mb} = 25 °C	-	13	А
I _{SM}	peak source current	pulsed; T _{mb} = 25 °C	-	53	А
Avalanche ru	uggedness				
E _{DS(AL)S}	non-repetitive drain-source avalanche energy	$\begin{split} I_D = 8 \text{ A}; \ V_{sup} &\leq 25 \text{ V}; \ R_{GS} = 50 \ \Omega; \\ V_{GS} &= 5 \text{ V}; \ T_{j(init)} = 25 \ ^\circ\text{C}; \ unclamped \end{split}$	-	25	mJ
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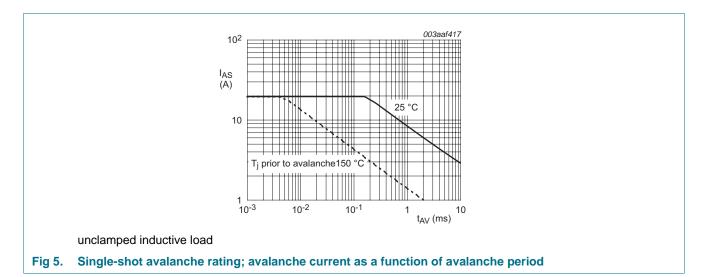


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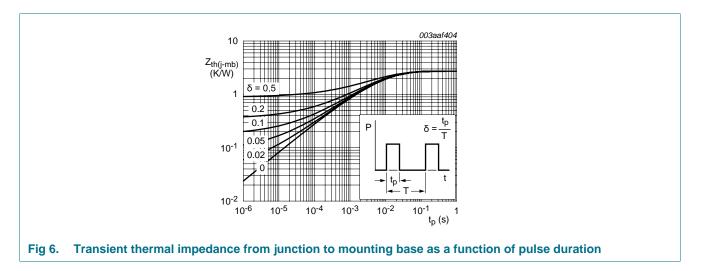
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5. Thermal characteristics

Table 5.Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R _{th(j-mb)}	thermal resistance from junction to mounting base		-	-	2.8	K/W
R _{th(j-a)}	thermal resistance from junction to ambient	in free air	-	60	-	K/W



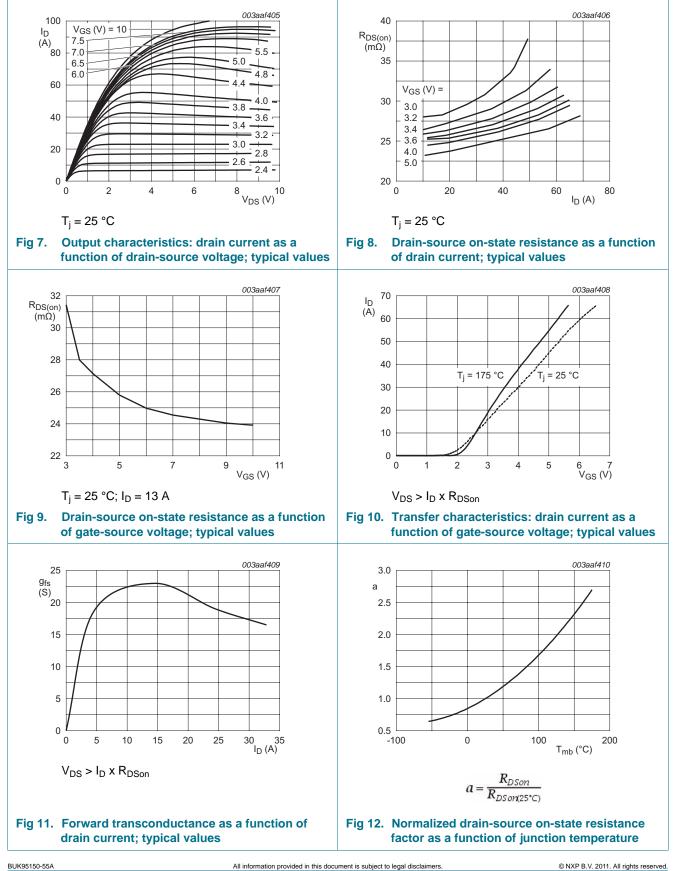
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6. Characteristics

Table 6.	Characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static cha	aracteristics					
V _{(BR)DSS}	drain-source breakdown	$I_D = 0.25 \text{ mA}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	55	-	-	V
	voltage	$I_D = 0.25 \text{ mA}; V_{GS} = 0 \text{ V}; T_j = -55 \text{ °C}$	50	-	-	V
V _{GS(th)}	gate-source threshold voltage	$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 25 \text{ °C}$	1	1.5	2	V
		$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 175 \text{ °C}$	0.5	-	-	V
		$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = -55 \text{ °C}$	-	-	2.3	V
I _{DSS}	drain leakage current	$V_{DS} = 55 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	0.05	10	μΑ
		$V_{DS} = 55 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 175 \text{ °C}$	-	-	500	μA
I _{GSS}	gate leakage current	$V_{GS} = 10 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	2	100	nA
		V _{GS} = -10 V; V _{DS} = 0 V; T _j = 25 °C	-	2	100	nA
R _{DSon}	drain-source on-state	V_{GS} = 4.5 V; I_{D} = 13 A; T_{j} = 25 °C	-	124	161	mΩ
	resistance	$V_{GS} = 5 \text{ V}; \text{ I}_{D} = 13 \text{ A}; \text{ T}_{j} = 175 \text{ °C}$	-	-	300	mΩ
		V _{GS} = 10 V; I _D = 13 A; T _j = 25 °C	-	116	137	mΩ
		V _{GS} = 5 V; I _D = 13 A; T _j = 25 °C	-	125	150	mΩ
Dynamic	characteristics					
C _{iss}	input capacitance	$V_{GS} = 0 V; V_{DS} = 25 V; f = 1 MHz;$	-	254	339	pF
C _{oss}	output capacitance	$T_j = 25 \ ^{\circ}C$	-	54	65	pF
C _{rss}	reverse transfer capacitance		-	42	58	pF
t _{d(on)}	turn-on delay time	$V_{DS} = 30 \text{ V}; \text{ R}_{L} = 1.2 \Omega; \text{ V}_{GS} = 5 \text{ V};$	-	6	6	ns
t _r	rise time	$R_{G(ext)} = 10 \ \Omega; \ T_j = 25 \ ^{\circ}C$	-	285	428	ns
t _{d(off)}	turn-off delay time		-	1	1.4	ns
t _f	fall time		-	18	25	ns
L _D	internal drain inductance	from drain lead 6 mm from package to centre of die ; $T_j = 25 ^{\circ}\text{C}$	-	4.5	-	nH
		from contact screw on tab to centre of die ; $T_j = 25 \text{ °C}$	-	3.5	-	nH
-s	internal source inductance	from source lead to source bond pad ; T _j = 25 °C	-	7.5	-	nH
Source-d	rain diode					
V _{SD}	source-drain voltage	$I_{S} = 53 \text{ A}; V_{GS} = 0 \text{ V}; T_{j} = 25 \text{ °C}$	-	1.1	-	V
		$I_{S} = 25 \text{ A}; V_{GS} = 0 \text{ V}; T_{j} = 25 \text{ °C}$	-	0.85	1.2	V
t _{rr}	reverse recovery time	$I_{S} = 53 \text{ A}; \text{ dI}_{S}/\text{dt} = -100 \text{ A}/\mu\text{s};$	-	24	-	ns
Qr	recovered charge	V_{GS} = -10 V; V_{DS} = 30 V; T_j = 25 °C	-	0.026	-	μC

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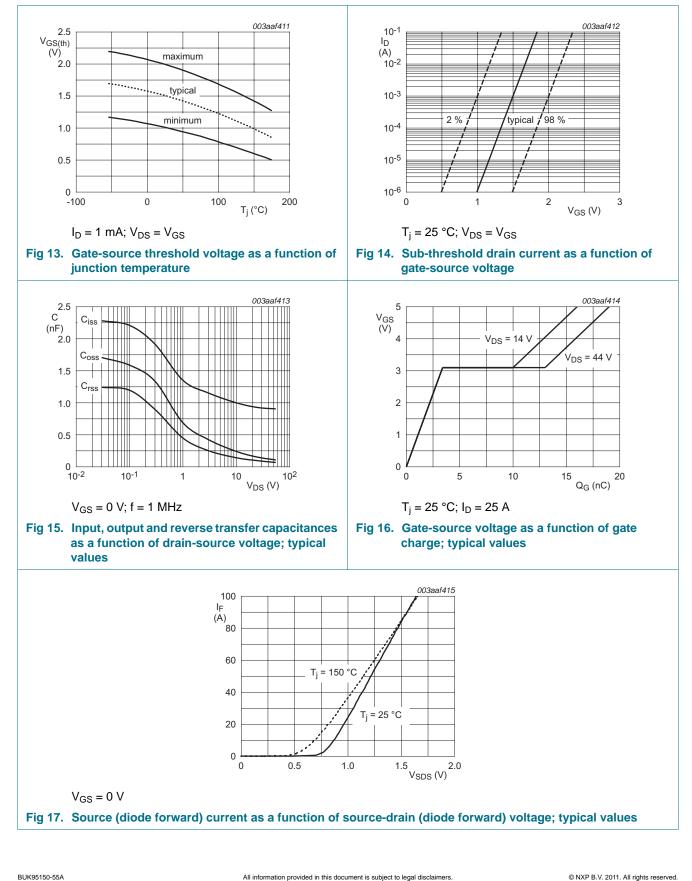
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7. Package outline

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								ş sca	1ale	 	L1 ⁽¹⁾ 3.30 2.79	L2		q 3.0 2.7	Q 2.6 2.2	
UNIT mm lote	A 4.5 4.1	A 1 1.39 1.27	b 0.9 0.6	b1 1.3 1.0	c 0.7	D 15.8	0 D 1 6.4	sca E 10.3	e	L 15.0	3.30	L ₂ max.	p 3.8	3.0	2.6	
UNIT mm lote . Term	A 4.5 4.1 nals in th	A 1 1.39 1.27	b 0.9 0.6	b1 1.3 1.0	c 0.7	D 15.8 15.2	0 D 1 6.4	E 10.3 9.7	e	L 15.0	3.30	L ₂ max.	p 3.8 3.6	3.0 2.7	2.6 2.2	
UNIT mm Note . Termi	A 4.5 4.1	A 1 1.39 1.27	b 0.9 0.6	b1 1.3 1.0 inned.	c 0.7 0.4	D 15.8 15.2	0 D1 6.4 5.9	SC4 E 10.3 9.7	e	L 15.0	3.30	L ₂ max.	P 3.8 3.6 EUR	3.0	2.6 2.2	 ISSUE DATE

Fig 18. Package outline SOT78A (TO-220AB)

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8. Revision history

Table 7. Revision histor	у			
Document ID	Release date	Data sheet status	Change notice	Supersedes
BUK95150-55A v.2	20110421	Product data sheet	-	BUK95150_96150-55A v.1
Modifications:		his data sheet has been ı IXP Semiconductors.	edesigned to compl	ly with the new identity
	 Legal texts have 	ve been adapted to the ne	w company name v	vhere appropriate.
	 Type number E 	BUK95150-55A separated	d from data sheet Bl	JK95150_96150-55A v.1.
BUK95150_96150-55A v.1	20000201	Product specification	-	-

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9. Legal information

9.1 Data sheet status

Document status [1] [2]	Product status 3	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

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